

March 2013

# FQB13N50C / FQI13N50C N-Channel QFET MOSFET

**500 V, 13 A, 480 m**Ω

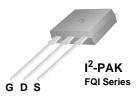
#### **Description**

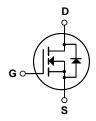
This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

#### **Features**

- 13 A, 500 V,  $R_{DS(on)}$  = 480 m $\Omega$  (Max) @ $V_{GS}$  = 10 V,  $I_D$  = 6.5 A
- Low Gate Charge (Typ. 43 nC)
- Low Crss (Typ. 20 pF)
- · 100% Avalanche Tested
- · RoHS compliant







## **Absolute Maximum Ratings** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQB13N50C / FQI13N50C	Units
V <sub>DSS</sub>	Drain-Source Voltage		500	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	°C)	13	Α
	- Continuous (T <sub>C</sub> = 100°C)		8	Α
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	52	Α
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	860	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	13	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	19.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
$P_D$	Power Dissipation (T <sub>C</sub> = 25°C)		195	W
	- Derate above 25°C		1.56	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C
'L			300	

#### **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.64	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	500			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to 25°C		0.5		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V			1	μΑ
		V <sub>DS</sub> = 400 V, T <sub>C</sub> = 125°C			10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6.5 A		0.39	0.48	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 40 \text{ V}, I_D = 6.5 \text{ A}$ (Note	4)	15		S
C <sub>oss</sub>	Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		180 20	235 25	pF pF
C <sub>rss</sub>	Reverse Transfer Capacitance			20	25	pF
Switchi	ing Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 13 A,		25	60	ns
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25 \Omega$		100	210	ns
$t_{d(off)}$	Turn-Off Delay Time			130	270	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4	5)	100	210	ns
$Q_g$	Total Gate Charge	V <sub>DS</sub> = 400 V, I <sub>D</sub> = 13 A,		43	56	nC
$Q_{gs}$	Gate-Source Charge	V <sub>GS</sub> = 10 V		7.5		nC
$Q_{gd}$	Gate-Drain Charge	(Note 4	5)	18.5		nC
Drain-S	Source Diode Characteristics ar	nd Maximum Ratings				
I <sub>S</sub>	Maximum Continuous Drain-Source Dic				13	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current				52	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 13 A			1.4	V
	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 13 A,		410		ns
t <sub>rr</sub>	Reverse Recovery Time	VGS - 0 V, IS - 10 A,		710		113

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L =6.0 mH,  $I_{AS}$  = 13A,  $V_{DD}$  = 50V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C 3.  $I_{SD}$  ≤ 13A, di/dt ≤ 200A/ $\mu$ s,  $V_{DD}$  ≤ BV $_{DSS}$ , Starting  $T_{J}$  = 25°C 4. Pulse Test : Pulse width ≤ 300 $\mu$ s, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

## **Typical Characteristics**

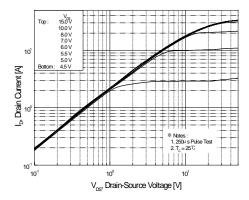


Figure 1. On-Region Characteristics

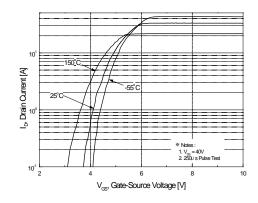


Figure 2. Transfer Characteristics

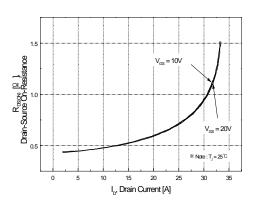


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

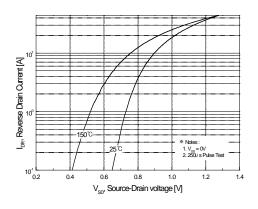


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

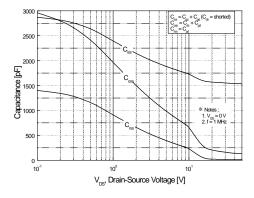


Figure 5. Capacitance Characteristics

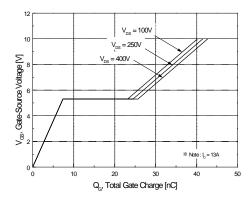


Figure 6. Gate Charge Characteristics

## Package Dimensions (Continued)

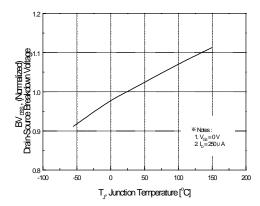


Figure 7. Breakdown Voltage Variation vs Temperature

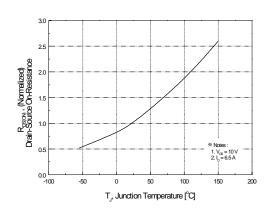


Figure 8. On-Resistance Variation vs Temperature

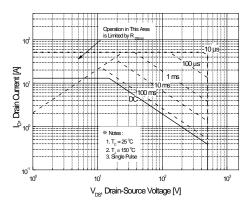


Figure 9. Maximum Safe Operating Area

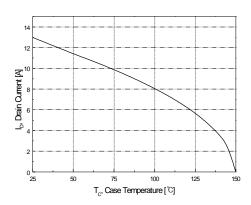


Figure 10. Maximum Drain Current vs Case Temperature

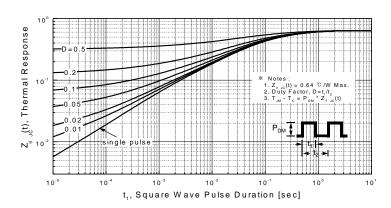
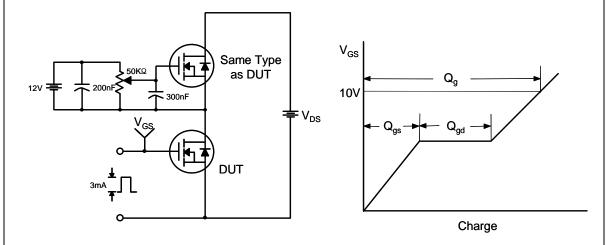
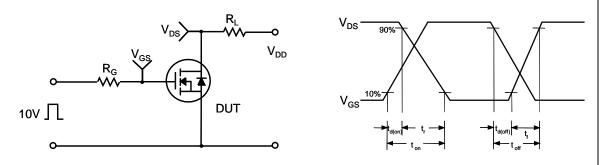


Figure 11. Transient Thermal Response Curve

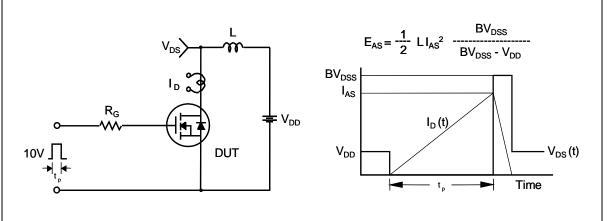
#### **Gate Charge Test Circuit & Waveform**



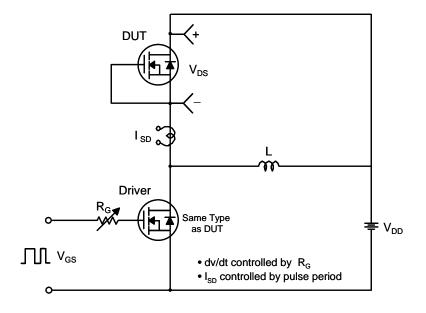
#### **Resistive Switching Test Circuit & Waveforms**

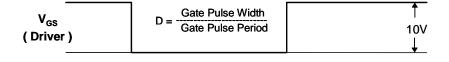


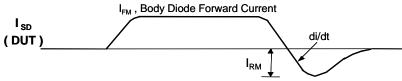
#### **Unclamped Inductive Switching Test Circuit & Waveforms**



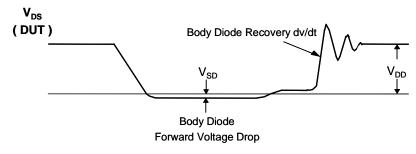
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms





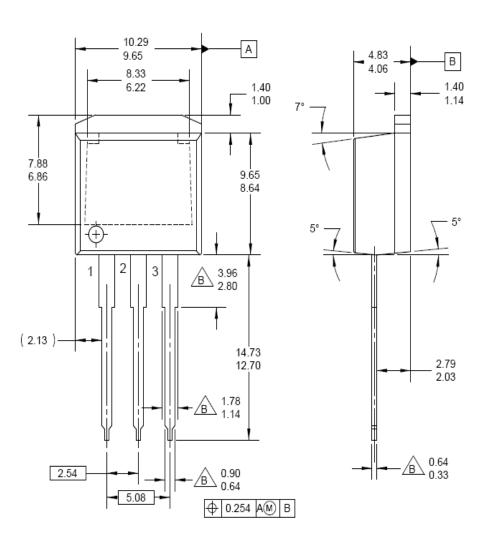


Body Diode Reverse Current



#### **Mechanical Dimensions**

I<sup>2</sup> - PAK



Dimensions in Millimeters

## **Mechanical Dimensions** D<sup>2</sup> - PAK -A-9.50 MIN 9.00 MIN 1.78 MAX 10.00 4.00 MIN (2.12) --1.50 MIN → 0.25 M B AM 5.08 5.08 LAND PATTERN RECOMMENDATION -B--6.22 MIN-1.65 1.14 6.86 MIN 15.88 14.61 SEE DETAIL A GAGE PLANE 0.25 0.10 B .25 MAX -(5.38)SEATING PLANE Dimensions in Millimeters





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Rev. 164